## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/058,651	BLUMENAU ET AL.	
Examiner	Art Unit	
Kyung H. Shin	2143	

SEARCHED					
Class	Subclass	Date	Examiner		
709	229	4/11/2006	кнѕ		
713	167, 168	Л	7		
713	183-185	,	η		
713	194	"	4		
713	189	"	"		
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
709	229	4/11/2006	кнѕ			
713	168	"	"			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated search in EAST, IEEE, ACM, and GOOGLE.	4/11/2006	кнѕ		
Consulted w/W. Vaughn & B. Jaroenchonwanit	4/11/2006	кнѕ		